Notice of References Cited

Application/Control No. 10/550,619	Applicant(s)/l Reexamination TANAKA ET	on
Examiner	Art Unit	
John Heyman	2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date . MM-YYYY	Name	Classification
*	Α	US-5,644,373 A	07-1997	Furushima et al.	349/158
*	В	US-5,945,965 A	08-1999	Inoguchi et al.	345/6
*	C	US-6,055,013 A	04-2000	Woodgate et al.	348/59
*	D	US-6,437,915 B1	08-2002	Moseley et al.	359/465
*	E	US-6,483,567 B1	11-2002	Okada, Satoshi	349/158
	F	US-			
	G	US-			
	Ξ	US-			· · · · · · · · · · · · · · · · · · ·
•	ı	US-			
	J	US-		•	•
	К	US-			•
	L	US-			
	Μ	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		, .			
	Р					
	Q		•	•	•	
	R					
	S					
	Т				•	

NON-PATENT DOCUMENTS

* Include as applicable: Author, Title D		as applicable: Author, Title Date, Publ	ate, Publisher, Edition or Volume, Pertinent Pages)		
	U		·.		
	V	·			
	w				
	x				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.